Application/Control No. Applicant(s)/Patent Under Reexamination 10/601,643 HATANO ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Seokyun Moon 2629 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY 02-2007 Yamazaki et al. 257/72 US-7,173,282 Α US-В US-С US-D US-E US-F US-G US-Н US-US-J Κ US-US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧

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